





Test report of

In Situ Temperature Measurement

And Lumen Maintenance Projection

Rendered to: LIGHT EFFICIENT DESIGN, DIV OF TADD LLC. 188 S. Northwest Highway Cary, IL 60013

For products: LED Lamp

Models: LED-8030M40-MHBC

Test date: Sep. 19, 2016 **Test laboratory:** LCTECH (Zhongshan) Testing Service Co.,Ltd 2/F., Technology and Enterprise Development Center, Guangyuan Road, Xiaolan, Zhongshan, Guangdong, China

Laboratory note:

Complied by:

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Project Engineer Sep. 27, 2016

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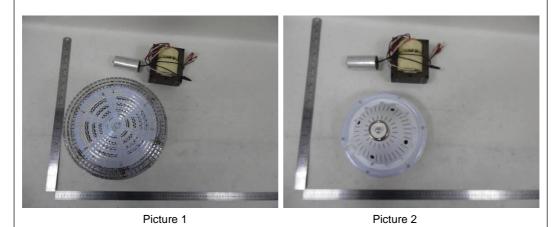
1 General

1.1 Products Information

	Photo
Quantity of Receipt Samples	1 units
Date of Receipt Samples	Sep. 7, 2016
	ELECTRONICS CO., LTD
LED Package, Array or Module	Model: SPMWHX1228FXXXXXXX, manufactured by SAMSUNG
Ballast	M59
Declared CCT	4000K
Rated Initial Lamp Lumens	N/A
Rated Power	210 W
Rated Inputs	277V, 60Hz
Model Number	LED-8030M40-MHBC
Lamp Type	LED Lamp
Brand Name	-

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Photo







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1.2 Reference standards or methods

The following standards are partly or totally used or referenced for test:

No.	Name
IEC 62560-2011 [#]	Self-ballasted LED-lamps for general lighting services by
	voltage>50V- Safety specifications
IES LM-80-08	Approved Method for Measuring Lumen Maintenance of LED Light
	Sources
IES TM-21-2011	Projecting Long Term Lumen Maintenance of LED Sources
IES LM-84-14 Annex A	Recommendations for measurement of In-situ conditions LED
	case Temperature, Ts

[#]Note: Standard IEC 62560-2011 only clause 10 cap temperature rise was tested . For reference only and IEC 62560-2011 is not in the scope of NVLAP recognition.

1.3 Equipment list

ID	Instrument	Model name	Cal. Date	Next cal. Date
AC Power supply	LC-I-923	CHP-500	2016-02-04	2017-02-03
AC Power supply	LC-I-987	APW-110N	2016-02-04	2017-02-03
Power analyzer	LC-I-954	WT210	2016-02-04	2017-02-03
Multimeter	LC-I-972	Fluke 17B	2016-08-10	2017-08-09
J thermocouple	LC-I-096	TT-J-30-SLE(200m/r)	2016-03-01	2017-02-28
Data acquisition/Switch unit	LC-I-098	34970A	2016-03-01	2017-02-28
Wireless T&H Transmitter	LC-I-978	DWRF-B	2016-02-03	2017-02-28





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2 Test conducted and method

2.1 Ambient Condition

Test was conducted in an ambient temperature of 25 \pm 5 °C. Ambient temperature variations above or below 25 °C was subtracted from or added to temperatures recorded at points on the luminaire. The ambient temperature was measured by a thermocouple which was immersed in 15 ml of mineral oil in a glass container.

2.2 Temperature Stabilization

Temperatures were measured after they have stabilized when the temperature were changing at a rate less than 1°C per hour and would not rise.

2.3 Thermocouples

Type J thermocouple was used for temperature measurement. The diameter of thermocouple conductor was 0.05mm².

2.4 Draught-free test enclosure

The lamp was positioned in a rectangular draught-proof enclosure with a double skin on the top and on at least three sides, and with a solid base. The double skins were of perforated metal, spaced apart approximately 150mm, with regular perforations of 1 mm to 2 mm diameter, occupying about 40% of the whole area of each skin. The internal surfaces of enclosure are painted with a matt paint.

2.5 Suspension methods

The luminaire was suspended in the ceiling of draught-free test enclosure.

2.6 Thermocouples contact

Thermocouples were in contact with the TMP_{LED} location described in LM-80 test report. In order to gain the maximum temperature, if appropriate, more than one thermocouple was contact in these locations. For details information, please refer to clause 3.3 for the photo of thermocouple contact.





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3 Test Result

3.1 Electrical data

Criteria Item	Result
Input voltage	277.06V~60Hz
Input current	1.301
Total power	208.2
Power factor	0.578

3.2 Temperature data

Criteria Item	Result	
Total operated period	8.0 hours	
Ambient temperature	25.4°C	
Measured maximum Temperature @TMPLED	76.8°C	
Maximum Temperature @TMP _{LED} (Normalized to 25°C)	<u>77.0°C</u>	

Note: TMP_{LED} was the maximum temperature LED which was selected based on the method of Annex A of IES LM-84-14

3.3 Lumen Maintenance Projection (IESNA TM-21 Method)

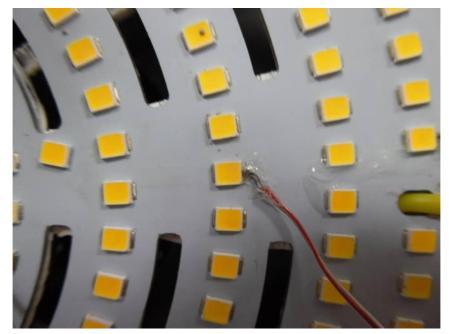
Criteria Item	Result	
10000 hours lumen maintenance of LED light source	94.20%	
forward current on each LED light source	150 mA	
Projected L ₇₀ lumen maintenance life	51000 hours	
Reported L ₇₀ lumen maintenance life	<u>51000 hours</u>	

Note: Please refer to appendix 2 and 3 for details of TM-21 inputs and results.





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Picture 1 Part view of hottest LED



Picture 2 Over view

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Shenz	hen BST Technology Co.	., Ltd.			
SAMSU	JNG ELECTRONICS CO	., LTD			
BS	T1510440900002Y- 1SR-	- 2			
SF	PMWHX1228FXXXXXXX	Х			
SF	PMWHX1228FXXXXXXX	Х			
	20 units				
150 mA					
55°C 75°C 85°C					
94.20% 94.04% 90.57%					
0.0042	0.0052	0.0059			
0.0042	0.0052	0.0059			
	SAMSI BS SF SF 55°C	150 mA 55°C 75°C 94.20% 94.04%			



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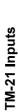
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ES1

LCTECH Appendix 2 TM-21 inputs



			LM-8	LM-80 Test Inputs	L		L	
Instructions	Description of LED Light Source Tested (manufacturer, model, catalog number)	7.0	Test D -	Fest Data for 55°C Case Temperature	Test D -	Test Data for 85°C Case Temperature	Test D.	^T est Data for 105°C Case Temperature
Yellow fields are completed by the user. Fields not used should be left	Model: SPMWHX1228FXXXXXXX, manufactured by SAMSUNG ELECTRONICS CO., LTD	SAMSUNG	Time (hours)	Lumen Maintenance (%)	Time (hours)	Lumen Maintenance (%)	Time (hours)	Lumen Maintenance (%)
blarik. Oyan rielus ale calculated based on user entries			0	100.00%	0	100.00%	0	100.00%
			1000	100.00%	1000	99.90%	1000	99.50%
First, enter a description of the LED			2000	99.61%	2000	98.84%	2000	98.33%
light source tested. Then complete			3000	98.81%	3000	98.26%	3000	97.35%
the fields labeled "LM-80 Testing			4000	98.35%	4000	97.77%	4000	96.44%
Details" Test duration must be at	LM-80 Testing Details		5000	97.79%	5000	97.36%	5000	95.63%
least 6,000 hours. If only one case	Total number of units tested per case temperature:	20	6000	97.34%	6000	96.72%	6000	94.81%
interruperature data set is to be used (no	Number of failures:	0	7000	97.00%	2000	95.74%	7000	92.70%
riterpolation), complete only rested	Number of units measured:	20	8000	96.42%	8000	94.69%	8000	92.22%
case temperature data sets complete	Test duration (hours):	10000	0006	95.49%	0006	94.51%	0006	91.44%
1 and 2.	Tested drive current (mA):	150	10000	94.20%	10000	94.04%	10000	90.57%
	Tested case temperature 1 (T _e , ⁰ C):	55						
Next, further to the right, in the	Tested case temperature 2 (T _e , ⁰ C):	85						
corresponding box(es) for each tested	Tested case temperature 3 (T _c , ^o C):	105						
case temperature, enter the test data		1						
along with the time (in hours) at which each measurement was taken Data								
entered must be normalized then								
averaged measured data (per TM-21								
sections 5.2.1 and 5.2.2).								
Enter drive current, <i>in-situ</i>								
temperature data and the percentage							L	
of initial lumens to project to in the	In-Situ Inputs							
fields labeled "In-Situ Inputs".	Drive current for each	150						
Results can be tailored to estimate	LED package/array/moune (mrv).	77						
lumen maintenance at a specific time	Demonstrate of initial lument to ansist to (see for							
by entering a value (t) in the yellow	Fercentage of initial juniters to project to (e.g. for L _m , enter 70):	70						
A complete TM-21 report will appear	Results							
on the next tab labeled "Report".								
	I ITTTE (1) at Which to estimate jumen maintenance (hours):	10,000						
	Lumen maintenance at time (t) (%):	94.20%						
	Calculated L70 (hours):	51,000						
	Reported L70 (hours):	51,000						

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LCTECH Appendix 3 TM-21 Results

TM-21 Report

	Tat	Table 1: Report at each LM-80 Test Condition	80 Test Conditi	ud		Table	Table 2: Interpolation Report
Description of LED Light Source Tested	nt Source Tested	_	xXXXXX, man	Model: SPMWHX1228FXXXXXXX, manufactured by SAMSUNG ELECTRONICS C	ECTRONICS C	(projection based T _{s,1} (°C)	projection based on <i>in-situ</i> temperature entered) 1 (°C) 55.00
catalog number)	, mouel, hber)					T _{s,1} (K)	328.15
Test Condition 1 - 55°C Case Temp	C Case Temp	Test Condition 2 - 85°C Case Temp	: Case Temp	Test Condition 3 - 105°C Case Temp	C Case Temp	α1	7.159E-06
Sample size	20	Sample size	20	Sample size	20	B1	1.017
Number of failures	0	Number of failures	0	Number of failures	o	T _{s,2} (°C)	85.00
DUT drive current used in the test (mA)	150	DUT drive current used in the test (mA)	150	DUT drive current used in the test (mA)	150	T _{s,2} (K)	358,15
Test duration (hours)	10,000	Test duration (hours)	10,000	Test duration (hours)	10,000	α2	7.253E-06
Test duration used for projection (hour to hour)	5,000 - 10,000	Test duration used for projection (hour to hour)	5,000 - 10,000	Test duration used for projection (hour to hour)	5,000 - 10,000	B2	1.008
Tested case temperature (°C)	55	Tested case temperature (°C)	85	Tested case temperature (°C)	105	E _a /k _b	5.09E+01
8	7.159E-06	B	7.253E-06	σ	1 102E 05	A	8.359E-06
	1.017	8	1.008	ш	1.009	Bo	1.013
Calculated L70(10k) (hours)	52,000	Calculated L70(10k) (hours)	50,000	Calculated L70(10k) (hours)	33,000	T _{s,i} (°C)	27.00
Reported L70(10k)	52,000	Reported L70(10k)	50,000	Reported L70(10k)	33,000	T _{s,i} (K)	350.15
						ë	7.229E-06
						Projected L70(10k) at 77ºC (hours)	51,000
						Reported L70(10k) at 77°C (hours)	51,000

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Votes: N.A

Company: LCTECH (Zhongshan) Testing Service Co.,Ltd.

Date:Sep. 22, 2016

Report Generated By: Bowen Pang







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****End of test report****